

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination 09/786,163 WOLF ET AL.	
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*	K	US-6,514,764 B1	02-2003	Willson, III, Richard C.	436/37
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*	M	US-5,807,683 A	09-1998	Brenner, Sydney	435/7.1

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	U	www.mathematische-bastelein.de/dice.htm
	V	Tom McNichol, "Totally Random: How two math geeks with a lava lamp and a webcam are about to unleash chaos on the internet", August 2003, Wired News, Issue 11.08.
	W	www.thefreedictionary.com word = hardware random number generator.
	X	cs.colgate.edu/faculty/revision.pub/OoPTTools/RandGen/RandomNumbers.htm

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	V	www.cs.sandia.gov/~jfaulon/MICS/kinetics/kinetics.htm
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